

Capabilities of femtosecond laser ablation ICP-MS for the major, minor, and trace element analysis of high alloyed steels and super alloys

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Abstract Femtosecond laser ablation inductively coupled plasma mass spectrometry was used for the quantification of 23 metallurgical relevant elements in unalloyed, alloyed and highly alloyed steels, and super alloys. It was shown that by using scanning mode ablation with large ablation spot diameters (250 μm), stable and representative sampling can be achieved for the majority of elements, except for bismuth and lead. For Bi and Pb up to 46%, temporal relative standard deviation (TRSD) was encountered, whereas for most other elements, the TRSDs were below 10%. Calibration with matrix-matched and non-matrix-matched standards provided similar agreement within the uncertainty of the certified values. However, the non-matrix-matched standard-based quantification was more influenced by interferences rather than ablation- or excitation-related matrix effects. The method was validated using 34 certified reference materials. ^{52}Cr , ^{51}V , or ^{55}Mn were used as internal standards due to the fact that the Fe concentration was not certified for the majority of reference materials. The determined concentrations for major and minor elements indicate that the total matrix internal standardization (100 wt.%) is applicable, which requires no knowledge about the steel samples prior to analysis.

Keywords Laser ablation · Mass spectrometry/ICP-MS · Metals/heavy metals · Femtosecond laser ablation ICP-MS · High alloyed steel · Trace contaminants

Introduction

The mechanical properties of alloyed steels and super alloys are not only dependent on the production process or the main constituents but are also critically affected by the concentration of trace contaminants ($<100 \text{ mg kg}^{-1}$) such as As, Bi, Sb, Se, Sn, Te, or Pb [1, 2, 3].

Currently, trace contaminants in steels and super alloys are often analyzed by solution-based methods such as inductively coupled plasma optical emission spectroscopy (ICP-OES) or ICP-MS. To access the trace element concentrations by ICP-OES or ICP-MS, matrix separation prior to the trace element analysis is required to avoid matrix effects and interferences. In ICP-OES, the emission line-rich concomitant metal matrix causes severe spectral interferences [4]. The analysis of trace contaminants by ICP-MS is hampered by isobaric and polyatomic interferences from argides, oxides, chlorides, and doubly charged ions [5] of main matrix elements. Moreover, clogging of the ICP-MS cones can only be circumvented by high sample dilution or the use of flow injection ICP-MS [13]. Matrix separation is often carried out by hydride generation or by liquid–liquid extraction [6, 4, 7]. The general disadvantage of matrix separation techniques is the lack of universality and general applicability as every protocol is suitable for a few elements only. Furthermore, solution-based analyses are rather time-consuming [12] and prone to contamination during sample dissolution (digestion in acid cocktails). Moreover, current steel production processes allows the analysis of trace element concentration in the final product

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only by liquid analysis. The time-consuming sample dissolution procedure is unsuitable for the monitoring of trace elements in each production step. Process analysis is only possible for the major and minor steel constituents using direct solid analysis techniques such as X-ray fluorescence spectroscopy (XRF), spark emission spectroscopy, glow discharge source (GD)-based techniques such as GD-OES, and dedicated elemental analyzers (carbon, oxygen, nitrogen, sulfur; based on sample combustion–molecular absorption).

Laser ablation ICP-MS (LA-ICP-MS) is recognized as a high-sensitivity direct solid analysis technique. Rapid, multi-elemental analysis from trace concentration levels (less than parts per million) up to the percent range have been performed in various applications [11]. Several publications describe the use of Q-switched Nd:YAG lasers for the analysis of minor and trace elements in metallurgical samples [14, 15]. These laser systems have pulse durations of a few nanoseconds. During the ablation, a “heat-affected zone” is generated, causing the formation of molten metal in and around the ablation spot. Furthermore, the nanosecond pulses can cause preferential vaporization which results in non-stoichiometric sampling [16]. Using femtosecond (fs) lasers for ablation, the formation of the “heat-affected zone” can be circumvented as the pulse duration falls below the material-specific thermal relaxation time. For unalloyed steel samples, it was shown that fs laser ablation produces an aerosol consisting of significantly smaller particles when compared to nanosecond laser-generated aerosols [17].

The aim of this study was to investigate the suitability of femtosecond LA-ICP-MS (fs-LA-ICP-MS) for fast, precise, and accurate analysis of trace contaminants in highly alloyed steels and nickel super alloys. Moreover, the multi-element capabilities of fs-LA-ICP-MS for the simultaneous quantification of major, minor, and trace elements in advanced metallurgical samples and related figures of merit were determined. Furthermore, non-matrix-matched quantification was investigated for major, minor, and trace elements. The method was validated using a total of 34 reference materials, such as unalloyed, alloyed, high alloyed steel certified reference materials (CRM), as well as nickel base alloy CRMs.

Experimental

Certified reference materials

Several CRMs were investigated within this study: unalloyed steels (BAM039-2, BCS451/1, BCS457/1, BCS460/1, ECRM085-1, ECRM090-1, JK2D, SRM364), alloy steels (BAM179-2, BAM184-1, BAM187-1, SRM1243, SRM1261a); highly alloyed steels (BAM227-1, BAM284-2, BAM286-1, BCS334, BCS462, BCS467/1, BCS475,

ECRM231-2, ECRM276-2, ECRM281-1, ECRM295-1, ECRM296-1, JK37, SRM1263a, SRM1264a, SRM346a); and nickel base alloys (BCS345, BCS346, BCS346A, BCS387/1, SRM897, SRM898, SRM899).

All CRMs were in the form of chips, except BCS345, BCS346A, JK2D, JK37, SRM1243, SRM1261a, SRM1263a, and SRM1264a which were used for analysis as discs. CRM chips were embedded in epoxy resin (Struers EpoFix) prior to the analysis. Machine grinding and polishing was accomplished using a commercial polisher/grinder (Struers LaboPol-5; grinding disc: MD Piano 600; polishing discs: MD Allegro, MD Mol, and MD Nap in combination with the appropriate Struers water-based diamond suspension polishing fluids). In order to circumvent potential surface corrosion, polished samples of unalloyed steels and alloy steels were stored in a desiccator. However, it needs to be mentioned that the sample preparation steps described here are not required for process analysis since the samples are commonly in the form of discs and surface contamination can be removed by ablation.

The uncertainties of the CRMs reported in Tables 2 and 3 and in the [Electronic Supplementary Material \(ESM\)](#) are reproduced as stated on the certificates. They represent in some cases the standard deviation of the average value and in other cases the half-width confidence interval $C(95\%)$ or are “based on judgment” by the manufacturer.

Laser ablation system

The laser beam (wavelength 795 nm; pulse duration of <150 fs) of a Ti:sapphire femtosecond laser (Legend, Coherent Inc., USA) was focused below the sample surface (~0.5 mm) by a single plano-convex lens ($f = 75$ mm). Thereby, the ablation crater diameter was controlled and crater shape distortion as observed by Koch et Al. [8] was circumvented. If not indicated differently, scanning ablation ($2 \mu\text{m s}^{-1}$ scan speed) with 250 μm crater diameter at a repetition rate of 10 Hz and 2 mJ pulse energy (resulting in a fluence of approx. 4 J cm^{-2} and irradiance of $2.7 \times 10^{13} \text{ W cm}^{-2}$) was used throughout the experiments. Some measurements were carried out in single hole drilling mode to compare the aerosol generation between the two modes of ablation. For each measurement, a 30 s gas blank was recorded followed by a 200 s sample ablation. The relatively long sample ablation time was selected to average potential spatial sample heterogeneities for elements such as lead and bismuth. The samples were ablated in a 30 cm^3 cylindrical ablation cell equipped with a helium inlet nozzle (0.5 mm nozzle inner diameter). The laser-induced aerosol was flushed with a constant helium flow of 1 L min^{-1} to an ICP-MS. An argon makeup gas flow of 0.85 L min^{-1} was admixed to the aerosol in front of the ICP to maintain optimum ICP operating conditions. When ablating epoxy-

Table 1 Measured isotopes

Quadrupole resolution	Isotopes
Standard resolution (~0.7 amu peak width)	^{11}B , ^{13}C , ^{66}Zn , ^{67}Zn , ^{69}Ga , ^{71}Ga , ^{75}As , ^{77}Se , ^{78}Se , ^{82}Se , ^{90}Zr , ^{91}Zr , ^{107}Ag , ^{109}Ag , ^{110}Cd , ^{115}In , ^{118}Sn , ^{119}Sn , ^{121}Sb , ^{126}Te , ^{128}Te , ^{181}Ta , ^{182}W , ^{203}Tl , ^{205}Tl , ^{206}Pb , ^{207}Pb , ^{208}Pb , ^{209}Bi
Increased resolution (~0.2- to 0.3 amu peak width)	^{27}Al , ^{46}Ti , ^{49}Ti , ^{51}V , ^{52}Cr , ^{53}Cr , ^{55}Mn , ^{57}Fe , ^{59}Co , ^{60}Ni , ^{61}Ni , ^{93}Nb , ^{95}Mo , ^{97}Mo

embedded chips, a minimum distance between the ablation site and the metal chip edge of 50 μm was maintained. This procedure was found sufficient to avoid the ablation of the thin metal edges together with the epoxy resin.

ICP-MS instrumental conditions

A quadrupole ICP-MS (Elan DRC II, PerkinElmer SCIEX, Canada) was coupled to the laser system for m/z detection. The ICP was operated at 1,350 W RF power, a plasma gas flow of 17 L min^{-1} , and an auxiliary gas flow of 0.7 L min^{-1} . A detector dwell time of 10 ms per m/z measured was used throughout the entire experiments. The measured isotopes are listed in Table 1. To avoid detector saturation, the isotopes of major alloy constituents were recorded with increased quadrupole resolution (0.3 amu). Thereby, the ion count rate was reduced by two to three orders of magnitude [18]. The ICP-MS was optimized prior to the analysis for highest signal/noise ratio while maintaining low oxide formation and doubly charged ion formation, respectively. To assure linearity between the detectors pulse and analog counting mode, a dual detector calibration was performed on a daily basis using BCS346.

Data processing and calibration

Data collection and processing was performed in accordance with the protocol reported by Longerich et al. [9]. Briefly, each sequence of up to 20 analyses started with the measurement of two replicates on a calibration standard. Then, three samples with five replicates each were measured. The sequence was closed with the measurement of two replicates on a calibration standard. Data reduction and quantification was performed using LAMTRACE [10]. BCS346 (nickel base alloy) and ECRM295-1 (highly alloyed steel) were used as calibration standards since these two CRMs cover the highest number of elements. Furthermore, NIST SRM610 (silicate glass) was also used as external calibration standard to determine the differences in the stoichiometry of fs-LA-generated aerosols of a conducting and non-conducting material and to study the capabilities of non-matrix-matched calibrations since most steel reference material contain a limited number of certified elements. Limits of detection were determined using the protocol given in [9].

Results and discussion

Single hole drilling experiments

Figure 1 shows the dependence of the ^{52}Cr and the ^{118}Sn fs-LA-ICP-MS signal (expressed as sensitivity) on the ablation spot diameter for BCS346. It was found that with increasing crater diameter, the sensitivity increases linearly. With the exception of Se, sensitivities of all recorded isotopes were increased by a factor of 1.5–2.8. This indicates that the fs-LA optical setup does not allow changing the crater diameter independent of the energy. The linear increase in sensitivity indicates that doubling the crater diameter leads to an increase in sensitivity of a factor of 2 only, which is mainly based on the reduced fluence and therefore reduced sample ablation. However, for ^{77}Se , ^{78}Se , and ^{82}Se , no increase in sensitivity was observed, which can be attributed to the low concentration of Se in BCS346 (9.1 mg kg^{-1}), resulting in low background-corrected Se signals (<1,000 cps).

The transient signals obtained with 100- and 150 μm ablation spot diameters showed a pronounced decrease in ion signal intensity by a factor of about 6 and 3, respectively, over an ablation period of 200 s due to the formation of a strong V-shaped crater. The element ratios of matrix elements are stable within 6%. However, to compensate for the well-known trace elemental heterogeneity in some of the

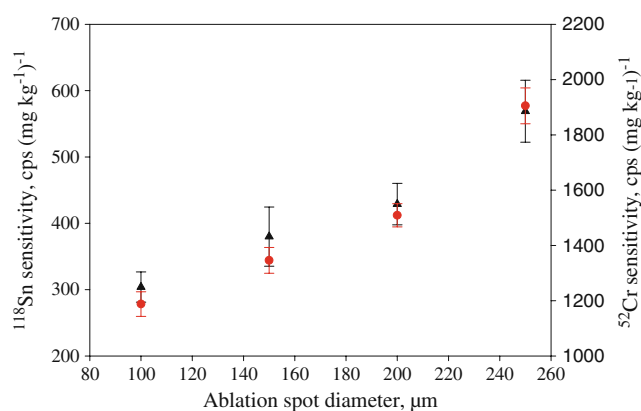


Fig. 1 Dependence of the ^{52}Cr sensitivity (circles) and the ^{118}Sn sensitivity (triangles) on the ablation spot diameter for BCS346 (2 mJ laser pulse energy, 10 Hz laser repetition rate, mean value of five different line scanning ablations)

Table 2 Analysis of BCS346 and ECRM295-1 using hole drilling ablation and matrix-matched calibration with ECRM295-1 and BCS346, respectively

Isotope	Unit	BCS346 (calibration with ECRM295-1)		ECRM295-1 (calibration with BCS346)	
		Mean value (± 2 standard errors, $n=5$)	Certified value	Mean value (± 2 standard errors, $n=5$)	Certified value
^{27}Al	wt.%	5.48 ± 0.06	(5.58)	0.0207 ± 0.0004	0.0203 ± 0.0005
^{51}V	wt.%	0.98 ± 0.01	(1)	0.0461 ± 0.0005	0.0456 ± 0.0015
^{52}Cr	wt.%	Internal standard		Internal standard	
^{53}Cr	wt.%	10.2 ± 0.2	(9.95)	19.16 ± 0.08	19.51 ± 0.08
^{59}Co	wt.%	14.1 ± 0.3	(14.71)	0.047 ± 0.002	0.045 ± 0.0011
^{75}As	ppm	52 ± 7	50.3 ± 2.5	40 ± 2	41 ± 2
^{95}Mo	wt.%	3.078 ± 0.04	(3.01)	3.9 ± 0.1	3.996 ± 0.024
^{97}Mo	wt.%	2.894 ± 0.05	(3.01)	4.1 ± 0.1	3.996 ± 0.024
^{118}Sn	ppm	79 ± 6	91 ± 8	29 ± 2	25 ± 3
^{119}Sn	ppm	79 ± 6	91 ± 8	29 ± 2	25 ± 3
^{121}Sb	ppm	42 ± 5	47 ± 4	7.8 ± 0.5	7 ± 1

^{52}Cr was used as internal standard. Values in parentheses are informative non-certified values. Only values of elements certified in both calibration standards are presented

samples, longer sampling was required and therefore large ablation spot diameters of 250 μm were applied. Thereby, the formation of V-shaped craters was circumvented and stable ICP-MS analyte signals were obtained.

Table 2 lists the measured elemental concentration in BCS346 (nickel base alloy) and ECRM295-1 (highly alloyed steel). Both materials were used as external calibration standard and sample. ^{52}Cr was used in both measurements as internal standard. The reason for using Cr as internal standard is based on the fact that the Fe concentrations are not certified within both materials. The results (Table 2) were found in agreement with the certified values. It is interesting to note that for Al, V, and Co, the concentration difference between the calibration standard and the CRM used as sample was larger than three orders of magnitude. The close agreement of the results for these elements with the certified values proves the high linear dynamic range of the calibration function as well as the applicability of the gas blank background correction when not having a real blank sample. Both must be regarded as an essential prerequisite for quantitative analysis using LA-ICP-MS.

Line scanning experiments

The selection of the ablation site for single hole drilling was found to be time-consuming as the embedded metal chip CRMs were often too thin after polishing to allow prolonged single hole drilling experiments. Therefore, line scanning ablation was investigated.

Figure 2 shows the dependence of the ^{52}Cr and the ^{118}Sn signal (mean value of five different line scanning

ablations) on the speed of the line scanning. For scan speeds between 1 and 10 $\mu\text{m s}^{-1}$, no significant change in the ^{52}Cr intensity was observed. When the scan speed was further increased to 40 $\mu\text{m s}^{-1}$, the analyte signal decreased by 20%. Similar behavior was observed for the other analytes (data not shown), which indicates that the reduction of signal intensity is not caused by ICP mass load effects and possibly more related to aerosol transport phenomena.

The temporal relative standard deviations (TRSD) of ^{52}Cr and ^{60}Ni in BCS346 were determined to be stable better than 5% when applying line scanning mode for sampling. However, for some trace elements, larger signal

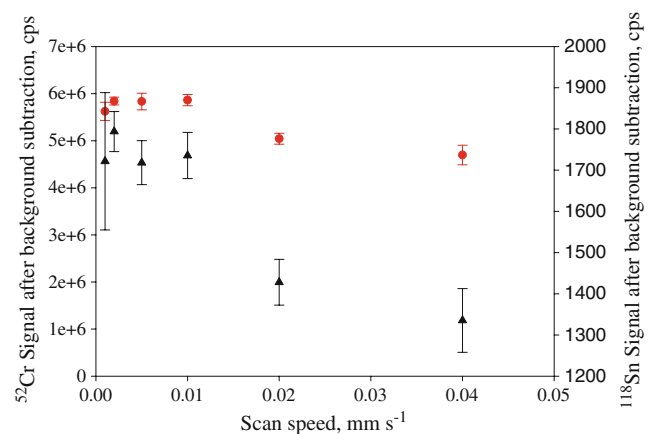


Fig. 2 Dependence of the ^{52}Cr signal (circles) and the ^{118}Sn signal (triangles) on the scan speed (250 μm ablation spot diameter, 2 mJ laser pulse energy, 10 Hz laser repetition rate, mean value of five different line scanning ablations) on JK37

fluctuations were encountered. Whereas ^{118}Sn was determined with a TRSD of 7%, the TRSD for ^{75}As and ^{208}Pb was 14% and 36%, respectively. These differences are explainable by the metallurgical properties of these elements. For example, the solubility of Sn within the metal matrix is low, whereas As and especially Pb are pushed to the grain boundaries during solidification. Therefore, it is understandable that Pb is more heterogeneously distributed within the sample, resulting in larger signal fluctuations when compared to the major elements. This effect was observed in all CRMs where the Pb concentration was above 30 mg kg^{-1} . It is interesting to note that for lead concentrations below 20 mg kg^{-1} , only TRSDs below 10% were observed.

The scan speed optimization was performed on a CRM in the shape of a solid disc (JK37). Constrained by the size of the epoxy-embedded metal chips (0.5–1 mm), a scan speed of $2 \text{ } \mu\text{m s}^{-1}$ was used for the analysis of all samples.

Quantitative analysis using non-matrix-matched calibration materials

The quantification capabilities for major, minor, and trace elements using non-matrix-matched calibration standards was investigated using SRM610 (silicate glass) [17,19,20]. This quantification procedure can be considered as an extreme case of non-matrix-matched calibration since the material properties should lead to significantly different amounts of ablated material when using the same fluence and should also influence the particle size distribution, which is critical for complete vaporization of the material within the ICP. Nevertheless, this approach is not only of academic interest but could also provide quantitative elemental information for elements (due to the large number of elements contained in SRM610) that are beyond the focus of today's steel CRM production.

Table 3 lists the measured elemental concentration in BCS346 and ECRM295-1. The measurements were performed in line scanning mode using $250 \text{ } \mu\text{m}$ -wide ablation spots. ^{52}Cr was used as internal standard. Deviations by a factor of 2 and larger between the certified and the measured values were observed for ^{67}Zn and ^{111}Cd . In both cases, significantly higher element concentrations were measured, which can be explained by interferences from $^{51}\text{V}^{16}\text{O}$ for ^{67}Zn and $^{95}\text{Mo}^{16}\text{O}$ for ^{111}Cd . A simple mathematical correction of the ^{67}Zn and ^{111}Cd signals was not possible due to the fact that ^{51}V and ^{95}Mo signals had to be acquired at increased mass filter resolution (custom resolution). Furthermore, for ^{66}Zn , higher values than the certified were obtained due to the interference by $^{50}\text{V}^{16}\text{O}$. Another example of an oxide interference is the determined Ni content in ECRM295-1 using ^{60}Ni . The $^{44}\text{Ca}^{16}\text{O}$

interference formed in SRM610 leads to an underestimation of the ^{60}Ni , whereas the ^{61}Ni is in good agreement with the certified value. Most interesting are the results for As, Ag, Sn, Sb, Tl, Pb, and Bi. These elements are typically considered as fractionating elements in ns-LA. However, the results in Table 3 demonstrate that the generated aerosol is representative for glass and steel samples because most of these elements are in good agreement with the certified values. Furthermore, the sum of all determined elements was 91.3% for BCS346 and 95.5% for ECRM295-1 when using the same isotopes as reported in Table 4. Therefore, a 100% normalization approach for calibration could also be used for unknown samples, eliminating the need of an internal standard.

Furthermore, it can be concluded that the isotope selection, when using non-matrix-matched calibration, becomes more critical. Oxide interferences must be taken into account and are in most cases more critical than the typically reported matrix effects. In most cases, a sector field ICP-MS would help solve the interference problems. Nevertheless, non-matrix-matched calibration using a silicate glass provides inferior accuracy compared to a calibration with metallic standards, but provides an alternative quantification approach. Different aerosol particle size distributions as reported in [17] can be excluded as a major source of uncertainty.

Matrix-matched quantitative analysis

For the matrix-matched calibration approach, BCS346 and ECRM295-1 were used as calibration standards. The sampling was carried out using the line scanning ablation mode. A complete list of all measured element concentrations in all CRMs is provided as ESM. ^{52}Cr was used as internal standard except for CRMs where no certified value for chromium was given. In these cases, either ^{51}V or ^{55}Mn was used as internal standard. Fe was excluded as internal standard due to the fact that the concentration of this element was certified only in few CRMs.

The determined element concentrations are in general in good agreement with the certified values. The quantification of low Al concentrations ($<0.005\%$) was hampered by the low signal intensity caused by the increased quadrupole resolution. However, due to different ablation efficiencies between the materials, even $0.0032 \text{ wt.}\%$ Al were successfully quantified for ECRM231-2. When using BCS346 as calibration standard, a significantly lower boron concentration was determined compared to the calibration with ECRM295-1. Although boron is not certified in BCS346, the certificate states a similar major element composition than in BCS345 (B certified, $190 \pm 20 \text{ mg kg}^{-1}$). With the exception of SRM1261a and SRM1263a, all determined boron values do not deviate from the certified values within

Table 3 Analysis of BCS346 and ECRM295-1 using a non-matrix-matched calibration with SRM610 (silicate glass)

Isotope	Unit	BCS346		ECRM295-1	
		Mean value (± 2 standard errors, $n=5$)	Certified value	Mean value (± 2 standard errors, $n=5$)	Certified value
¹¹ B	ppm	245 \pm 44	(190)	17.8 \pm 0.6	18 \pm 1
²⁷ Al	wt. %	5.44 \pm 0.02	(5.58)	0.0197 \pm 0.0007	0.0203 \pm 0.0005
⁴⁹ Ti	wt. %	4.61 \pm 0.08	(4.75)	0.0021 \pm 0.0001	
⁵¹ V	wt. %	0.97 \pm 0.02	(1)	0.0446 \pm 0.0006	0.0456 \pm 0.0015
⁵² Cr	wt. %	Internal standard		Internal standard	
⁵³ Cr	wt. %	9.49 \pm 0.03	(9.95)	18.62 \pm 0.04	19.51 \pm 0.08
⁵⁵ Mn	wt. %	0.00096 \pm 0.00002		1.89 \pm 0.02	1.758 \pm 0.009
⁵⁷ Fe	wt. %	0.0702 \pm 0.0006		50.2 \pm 0.7	48.36 \pm 0.11
⁵⁹ Co	wt. %	13.44 \pm 0.05	(14.71)	0.039 \pm 0.001	0.045 \pm 0.0011
⁶⁰ Ni	wt. %	54.5 \pm 0.4		21.0 \pm 0.1	24.4 \pm 0.04
⁶¹ Ni	wt. %	58.2 \pm 0.8		23.8 \pm 0.2	24.4 \pm 0.04
⁶⁶ Zn	ppm	39 \pm 1	28.9 \pm 1.6	3.26 \pm 0.05	
⁶⁷ Zn	ppm	74.3 \pm 0.8	28.9 \pm 1.6	3.6 \pm 0.5	
⁶⁹ Ga	ppm	56.7 \pm 0.4	50.6 \pm 1.4	32.3 \pm 0.5	
⁷¹ Ga	ppm	56.9 \pm 0.4	50.6 \pm 1.4	32.4 \pm 0.5	
⁷⁵ As	ppm	47 \pm 4	50.3 \pm 2.5	43.0 \pm 0.9	41 \pm 2
⁷⁷ Se	ppm	5 \pm 2	9.1 \pm 0.9	<2	
⁷⁸ Se	ppm	9 \pm 2	9.1 \pm 0.9	<7	
⁸² Se	ppm	5 \pm 2	9.1 \pm 0.9	<2	
⁹⁰ Zr	wt. %	0.035 \pm 0.005	(0.044)	0.000018 \pm 0.000004	
⁹¹ Zr	wt. %	0.035 \pm 0.005	(0.044)	0.000048 \pm 0.000004	
⁹⁵ Mo	wt. %	2.67 \pm 0.02	(3.01)	3.60 \pm 0.07	3.996 \pm 0.024
⁹⁷ Mo	wt. %	2.72 \pm 0.02	(3.01)	3.79 \pm 0.09	3.996 \pm 0.024
¹⁰⁷ Ag	ppm	34 \pm 4	35 \pm 1	0.32 \pm 0.03	
¹⁰⁹ Ag	ppm	34 \pm 4	35 \pm 1	0.35 \pm 0.01	
¹¹¹ Cd	ppm	2.9 \pm 0.1	0.42 \pm 0.06	3.3 \pm 0.1	
¹¹⁸ Sn	ppm	81 \pm 8	91 \pm 8	29 \pm 1	25 \pm 3
¹¹⁹ Sn	ppm	77 \pm 8	91 \pm 8	27 \pm 1	25 \pm 3
¹²¹ Sb	ppm	45 \pm 4	47 \pm 4	7.8 \pm 0.2	
²⁰³ Tl	ppm	1.7 \pm 0.3	1.8 \pm 0.2	<0.02	
²⁰⁵ Tl	ppm	1.7 \pm 0.3	1.8 \pm 0.2	<0.005	
²⁰⁶ Pb	ppm	19 \pm 3	21 \pm 1	0.73 \pm 0.04	
²⁰⁷ Pb	ppm	20 \pm 3	21 \pm 1	0.67 \pm 0.02	
²⁰⁸ Pb	ppm	19 \pm 3	21 \pm 1	0.70 \pm 0.02	
²⁰⁹ Bi	ppm	12 \pm 3	10.4 \pm 0.4	0.044 \pm 0.002	

⁵²Cr was used as internal standard. Values in parentheses are informative non-certified values

the uncertainty of the measurement when using ECRM295-1 for calibration.

Although scanning ablation mode and large ablation crater diameters were selected to achieve long and stable ablation signals, TRSDs of Pb and Bi were rather large (maximum found in SRM1264a: 46% for ²⁰⁸Pb and ²⁰⁹Bi) compared to the other trace elements investigated (TRSD below 10% for element concentrations >5 mg kg⁻¹). This trend was observed in all CRMs where the Pb

concentration exceeded ~20 mg kg⁻¹ and the Bi concentration exceeded ~5 mg kg⁻¹ and independent of the large variety of main element composition in the investigated CRMs. For Cd, Ga, Sb, Sn, Te, Tl, and Zn, no concentration dependence of the TRSD values was encountered. The variation of the TRSDs for Ag and As were found in several CRMs larger than 10%, although no correlation to the matrix constituents or the concentration was found.

Table 4 MDL for calibrations with BCS346 or ECRM295-1

	MDL for BCS346 (mg kg ⁻¹)	MDL for ECRM295-1 (mg kg ⁻¹)
¹¹ B	0.2	0.3
²⁷ Al	0.06	0.05
⁴⁹ Ti	0.06	
⁵¹ V	0.01	0.01
⁵² Cr	2	2
⁵⁵ Mn		0.01
⁵⁷ Fe		0.4
⁵⁹ Co	3	3
⁶⁰ Ni		1
⁶⁶ Zn	0.06	
⁶⁹ Ga	0.006	
⁷⁵ As	0.04	0.03
⁷⁷ Se	0.4	
⁹⁰ Zr	0.003	
⁹⁵ Mo	0.2	0.2
¹⁰⁷ Ag	0.008	
¹¹¹ Cd	0.01	
¹¹⁸ Sn	0.006	0.005
¹²¹ Sb	0.006	0.005
¹²⁶ Te	0.07	
²⁰⁵ Tl	0.002	
²⁰⁸ Pb	0.008	
²⁰⁹ Bi	0.002	

Table 4 reports typical method detection limits (MDL) for calibrations using BCS346 or ECRM295-1. As stated by Longerich et al. [9] in laser ablation, MDLs are calculated from the gas blank. Statistically significant MDL values are only attained if a sufficiently large number of estimates are used. The reported values are the median of 16 individual MDLs obtained over a period of several days. For elements certified in both calibration standards, a good agreement between the two MDLs was observed. The MDLs indicate that the parameters optimized within this study are sufficient for routine analysis of steels and alloys and exceed partially the capabilities of solution nebulization ICP-MS after dissolution.

Conclusion

The capabilities of fs-LA-ICP-MS for quantitative analysis of major, minor, and trace elements in steels (unalloyed, alloyed, and highly alloyed) and super alloys were investigated. Thirty-four CRMs sampled using line scanning ablation mode covered a wide range of steel matrix compositions. It was shown that by using a matrix-matched

calibration with a highly alloyed steel (ECRM295-1) and a nickel base alloy (BCS346), an excellent agreement between certified and determined value can be attained for a wide variety of elements, even when the difference in concentration between calibration standard and sample is several orders of magnitude.

Non-matrix-matched calibration using NIST SRM610 glass standard provided similar results in comparison to the matrix-matched calibration approach. The results indicate minimum fractionation between the two very different matrices. However, deviations between the certified and determined values encountered were caused by polyatomic and matrix interferences rather than differences in the stoichiometry of the fs laser-generated aerosols between the matrices. Furthermore, it is demonstrated that the analysis of two different matrices requires very careful selection of isotopes to avoid interferences.

Throughout this work, internal standardization with ⁵²Cr, ⁵¹V, or ⁵⁵Mn was applied. As the sum of all determined elements was found for all CRMs well above 90%, a 100% normalization approach can be expected to result in comparable results. Nevertheless, in industrial routine analysis, the concentration of the main elements will be known to the analyst almost always from other well-established direct solid sampling techniques, such as XRF. Therefore, fs-LA-ICP-MS could extend the range of elements which need to be determined in time critical processes and would shorten the response time significantly since an established procedure requires <60 s for one analysis.

Most of the CRMs used in this investigation are not qualified for microanalysis—and they were also not prepared for this purpose. The same also applies to “real samples.” We were well aware of these facts and therefore paid close attention to the structure of the ablation signals. As stated above, our aim was the quantification of analytes in the bulk material and the comparison of the attained values with the certified ones. We used a large number of CRMs to clearly and undoubtedly prove that neither the sample matrix must be closely matched to the calibration standard matrix nor that sample heterogeneity causes significant deviations from the certified values. Only successful validation of the method for bulk analysis provides the necessary confidence and justification for the application of this method for microanalysis. The potential heterogeneity of the used CRMs should not be considered a problem for the method but rather an overcome challenge. Furthermore, in the context of steel analysis, LA-ICP-MS should not be called “semi-quantitative” anymore.

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